

Project

- XC parroted Friday 9AM → messy 9AM
- leakage: source/body, gate-drain
- SRP B7 → B6 transition

Noise

Environmental
thermal
1/f

Lower limit set by noise

Environmental noise

60 Hz

Power line, power supply noise

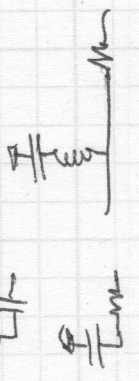
RF: cell, wifi, microwave

Solutions: filtering

Shielding

co-axial

twisted pair



MVDC works great, I'm adding bits!
My PCR works great, I can amplify anything
What sets lower limit?

e.g. -mK temp resolution

- Strain gauge sensor amplifier 1uV, 2DC
- 1uV, 2450 ± 10MHz

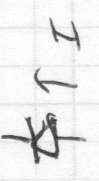
Intrinsic noise

Shot noise

Thermal noise

1/f noise

Shot noise - uncorrelated carriers over
bandwidth, e.g. diodes



IF my current is 466 pA

$$1.6 \times 10^{-19} \frac{C}{s} =$$

$$(1.6 \times 10^{-19}) \frac{(6.6 \times 10^{18})}{10^7}$$

$$1.6 \times 10^{-19} \frac{C}{s}$$

1uV/240A 17sp W14L2

$I = 1.66 \text{ pA}$ do they arrive once per 0.1 μs ?

In a resistor low-R wire, yes. (fish. see below)

In a diode, no.

$\frac{I_{rms}}{I} = \text{average current}$

actual current is noisy, $I + \bar{I}_n$

$$\bar{I}_n^2 = 2 q I \Delta f$$

$$\bar{I}_n = \sqrt{2 q I \Delta f}$$

e.g. $\sqrt{2 \times 1.6 \times 10^{-19} \times 5 \times 10^{-14} \times (5 \text{ Hz})}$

$$= 10^{-4} \frac{\text{C}}{\text{s}} \text{ in a } 1 \text{ Hz BW}$$

$$k_B T = (1.38 \times 10^{-23} \frac{\text{J}}{\text{K}}) (300 \text{K}) = 4 \times 10^{-21} \text{ J}$$

$$1 \text{ J} = 1 \text{ W} \cdot \text{s} = 1 \text{ W} / \text{Hz}$$

$$k_B T = 4 \times 10^{-21} \frac{\text{W}}{\text{Hz}}$$

at room temp

Equipartition

$$\frac{1}{2} C \quad \text{---} \quad \text{---}$$

$$E = \frac{1}{2} C V^2$$

$$E = \frac{1}{2} L I^2$$

$$\bar{E}_n = \frac{1}{2} k_B T = \frac{1}{2} C \bar{V}_n^2$$

say $C = 1 \text{ pF}$

$$\bar{V}_n^2 = \frac{k_B T}{C} = \frac{4 \times 10^{-21} \text{ J}}{1 \text{ pF}} = 4 \times 10^{-9} \frac{\text{J}}{\text{C}^2} \approx 60 \mu\text{V}$$

avg. Energy

Thermal noise - random motion due to temperature

Brownian motion

Johnson noise

white noise

2 Key theorems

1) Equipartition $\bar{E}_n = \frac{1}{2} k_B T$

every storage node has, on average $\frac{1}{2} k_B T$

2) Fluctuation/dissipation $\bar{P}_N = 4 k_B T \Delta f$

every dissipative element causes fluctuation

Fluctuation/dissipation

$$\bar{P}_N = 4 k_B T \Delta f = \bar{V}_n^2 / R$$

$$\bar{V}_n^2 = 4 k_B T R \Delta f \quad \text{say } R = 1 \text{ k}\Omega$$

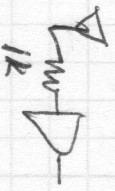
$$\bar{V}_n = \sqrt{4 (4 \times 10^{-21} \frac{\text{J}}{\text{K}}) (10^3 \Omega) \Delta f}$$

$$= 4 \text{ nV} / \sqrt{\text{Hz}} \sqrt{\Delta f}$$

say RF amp for 2.4 GHz $\pm 1 \text{ MHz}$

$$\Delta f = 2 \text{ MHz}$$

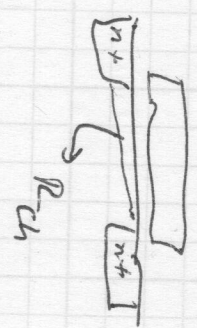
$$\bar{V}_n = (4 \frac{\text{nV}}{\sqrt{\text{Hz}}}) (\sqrt{10^6}) = 4 \mu\text{V}$$



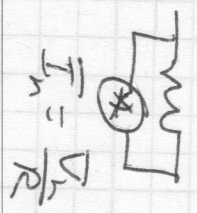
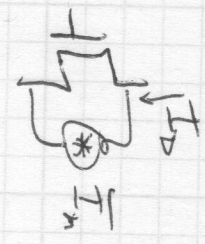
sets minimum detectable signal power

voltage

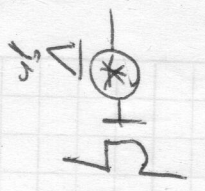
What about the amplifier?



Thermal/Johnson/Newton



$$\overline{I_n^2} = \frac{4k_B T}{R_{ch}} \Delta f$$

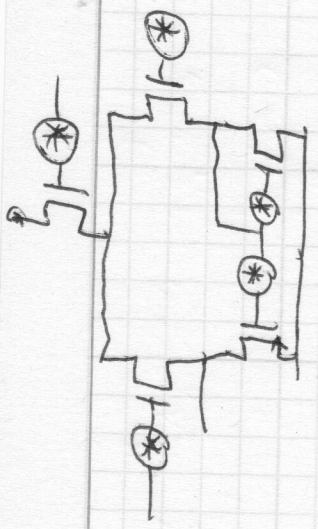


$$\overline{V_n} = \sqrt{4k_B T \left(\frac{2}{3} \frac{1}{S_m}\right) \Delta f}$$

$$g_m = 1 \text{ mS} \quad \frac{1}{S_m} = 1 \text{ K}\Omega$$

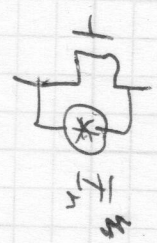
$$\overline{V_n} \approx 4 \text{ nV} \sqrt{\Delta f} \sqrt{\frac{2}{3}}$$

every transistor has this noise!
Input?



maybe!

$$R_{ch} \approx \left(\frac{3}{2}\right) \left(\frac{1}{S_m}\right) \text{ for noise calculations}$$



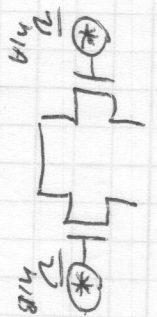
what is the equivalent gate noise that would give noise that would

give me the same drain noise?

$$\overline{I_n^2} = g_m \overline{V_n^2} \Rightarrow \overline{V_n^2} = \frac{\overline{I_n^2}}{g_m^2}$$

$$= \frac{4k_B T \left(\frac{3}{2} \frac{1}{S_m}\right) \Delta f}{S_m^2}$$

all noise sources are uncorrelated so their powers add, not magnitudes.
Input pair input or output



$$\overline{V_{n,out}^2} = (A_V \overline{V_{n,IA}})^2 + (A_V \overline{V_{n,IB}})^2$$

$$\overline{V_{n,out}^2} = \frac{\overline{V_{n,out}^2}}{A_V^2}$$

$$= \sqrt{2} \overline{V_{n,IA}}^2$$

$$\overline{V_{n,eq}} = \sqrt{2} \overline{V_{n,IA}}$$



current mirror $V_{root}^2 = 2(g_{m2} R_o \overline{V}_{n2})^2$

$$\overline{V}_{n2}^2 = \frac{2(g_{m2} R_o)^2 \overline{V}_{n2}^2}{(S_{m1} R_o)^2}$$

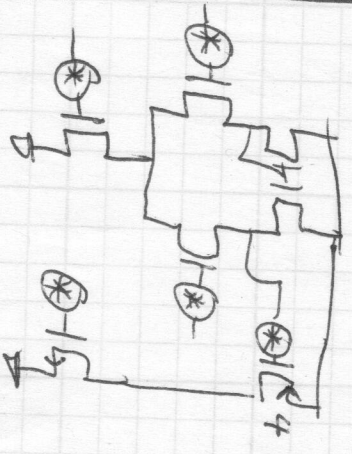
effect of mirror noise can be reduced by reducing gain to output, i.e. reduce g_{m2} relative to g_{m1}

both have same I_D , so change $V_{ov} \gg V_{ovm}$

LNA - low noise amplifier

at the beginning of an analog chain, take particular care to get low noise and some gain. After that, it doesn't matter as much.

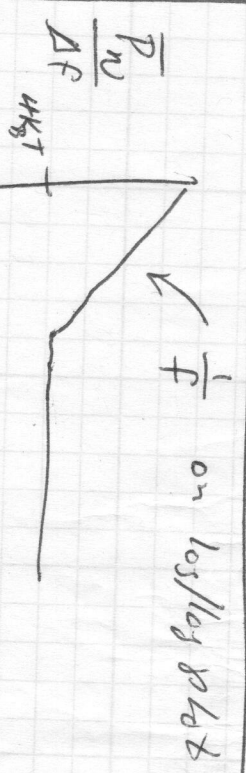
what about 2 stages?



forward gain for \overline{V}_{n4} is A_{v2} to reflect back to input

$$\overline{V}_{n4}^2 = \frac{(A_{v2} \overline{V}_{n4})^2}{(A_{v1} A_{v2})^2} = \frac{\overline{V}_{n4}^2}{A_{v1}^2}$$

forward gain m_3 is small



charge trapping under gate?